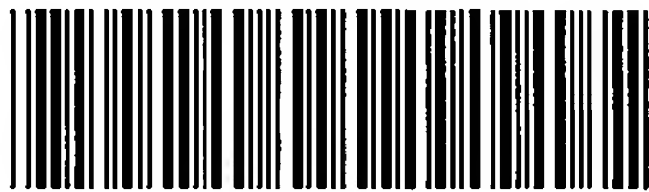


Search Notes

Application/Control No.

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Examiner

Pierre-Louis Desir

Applicant(s)/Patent under
Reexamination

CHUN, CHANG-HYEN

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
455	442	9/13/2006	PD
455	436	9/13/2006	PD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	9/13/2006	PD